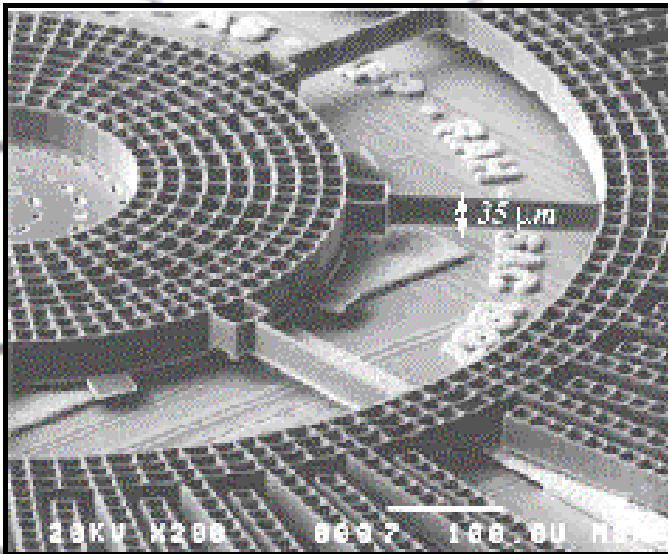
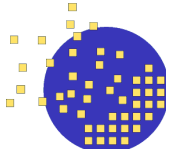


MicroAssembly Technologies



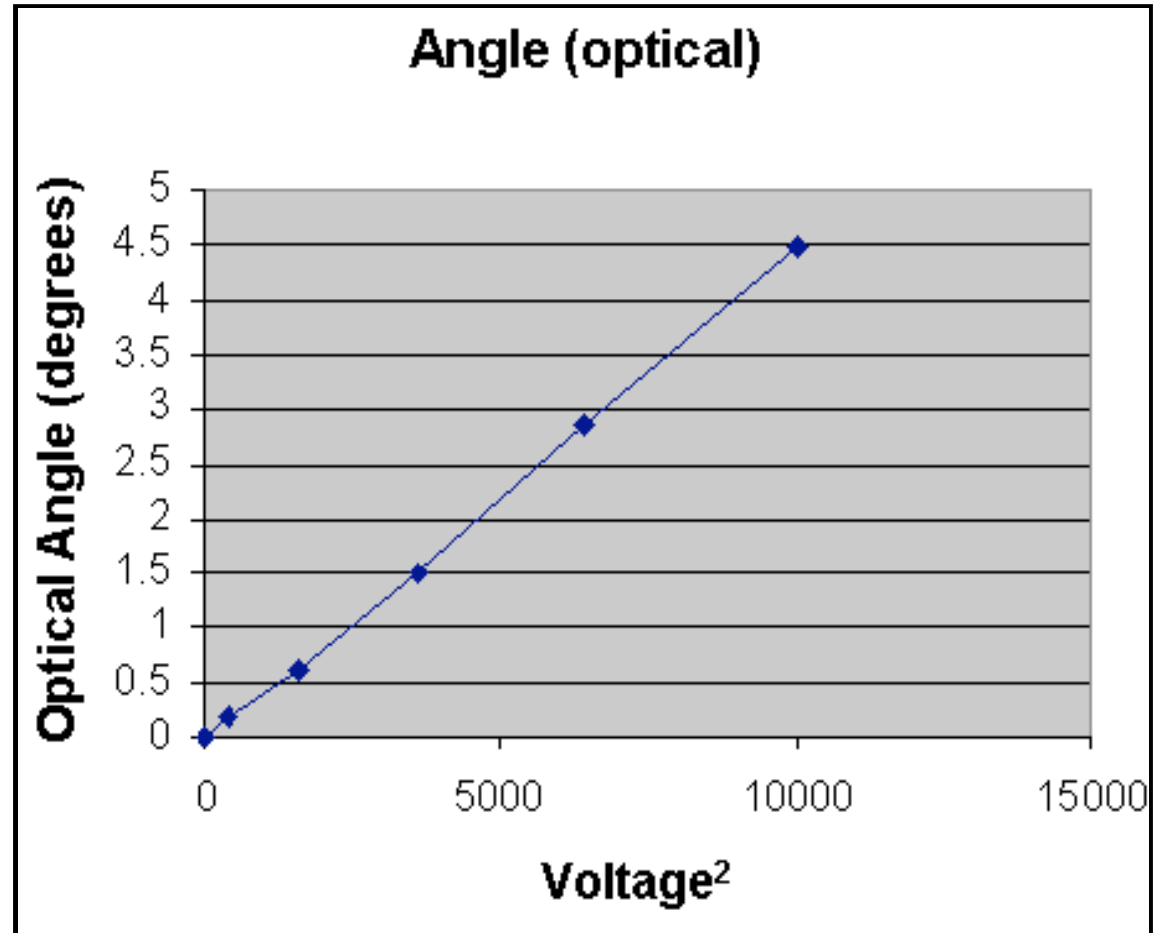
- **MEMS SLMs**
- **MEMS-CMOS Integration**
- **High Force Actuators**
- **Low Temperature Bonding**
- **Nanolaminate Bonding**

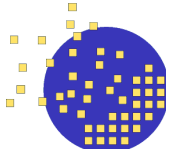
Wallace Tang, President wallacet@microassembly.com



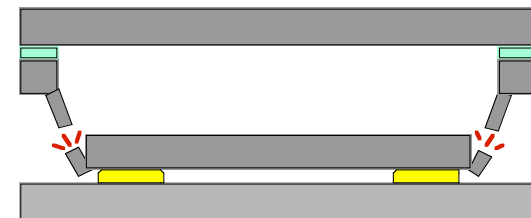
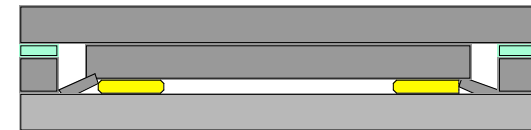
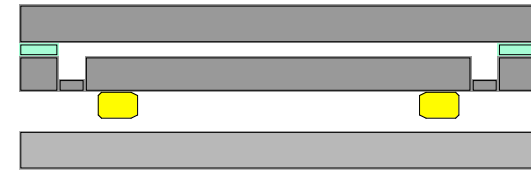
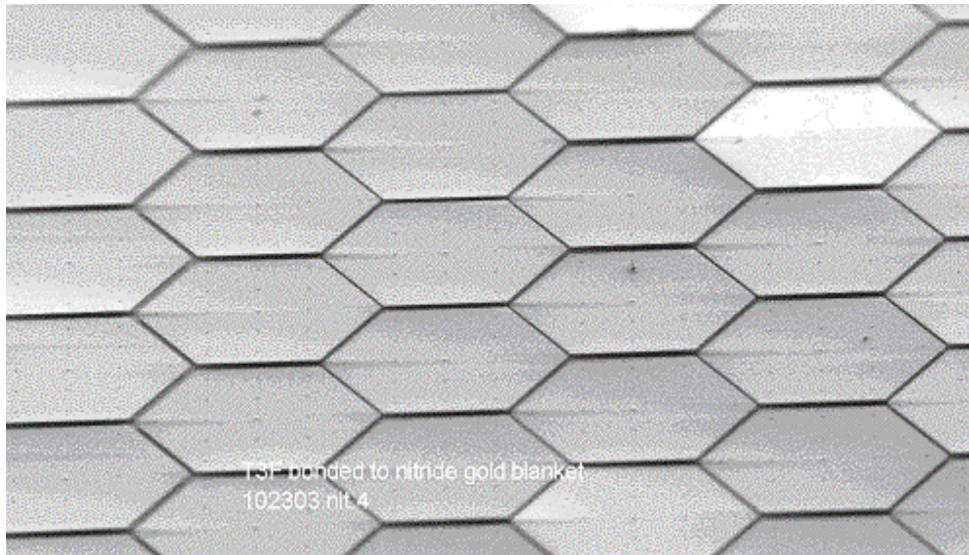
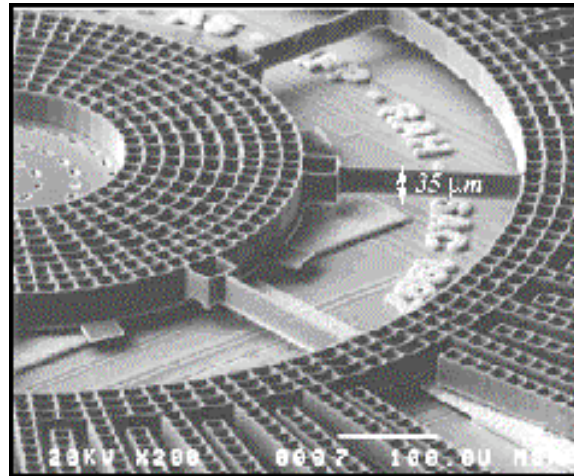
Product: MEMS SLM

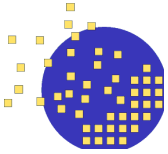
- High Performance Tip-Tilt-Piston Actuators
- Reflector Transfer
- Linear Response
- DoD Contracts (AFOSR, DARPA, MDA)





Tool: MEMS Transfer Process

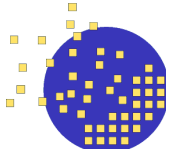




Low Temperature Bonding

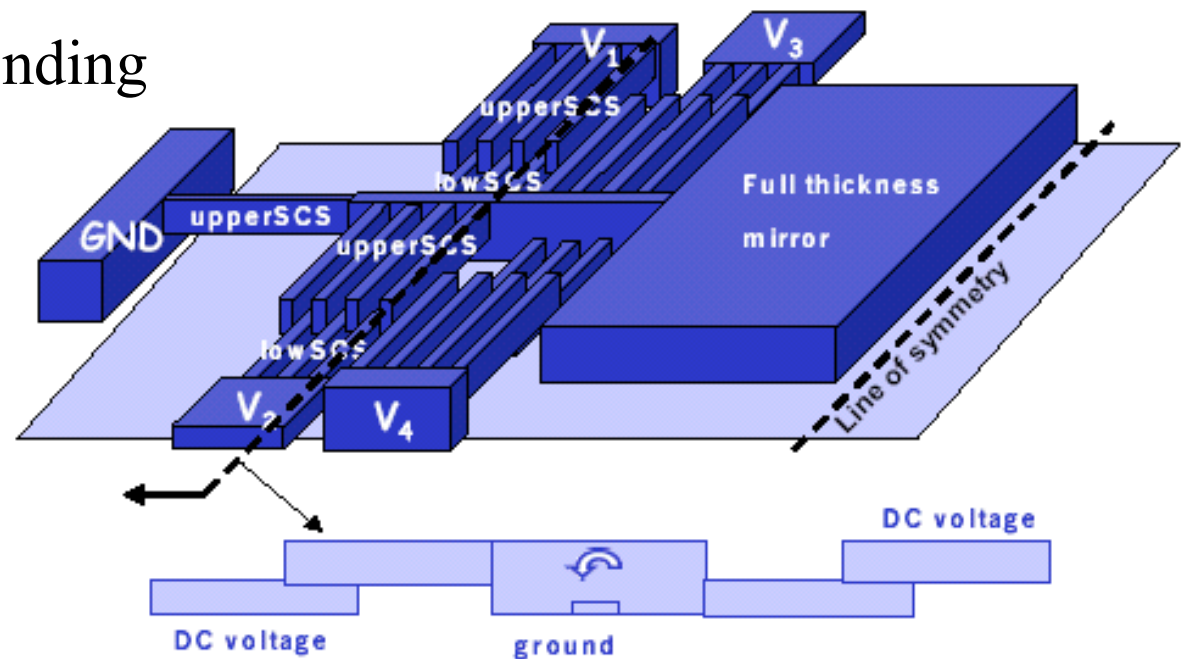
- 300°C standard CMOS-compatible process, room temperature for Silicon substrates
- Thousands of reflectors at a time
- MEMS-CMOS Integration: Monolithic performance
- Hermetic/vacuum sealing

- Microbump integration: 100% yield, N=1024
- Pilot production

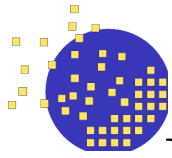


Relevant Technologies

- Electrostatic Comb Drive Piston Actuators*
 - Thick and Thin Single Crystalline Silicon (SOI) Mirrors
 - 5 Generations of Actuator Design & Fabrication (in collaboration with ARI)
 - Cryo Devices
- Nanolaminate Bonding



* patents pending



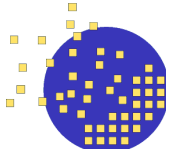
High Performance Piston Actuators

Relevant Part Under Development

- Comb drive piston actuators
- Piston stroke: 6 μm
- Frequency response: 27 kHz
- Size: 300 μm

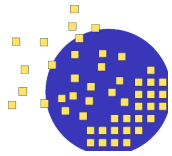
- Conservative fabrication design rules (less than 10:1)
- Possible: Larger stroke, higher frequency response
- Already demonstrated much faster tip-tilt-piston devices*

* patents pending

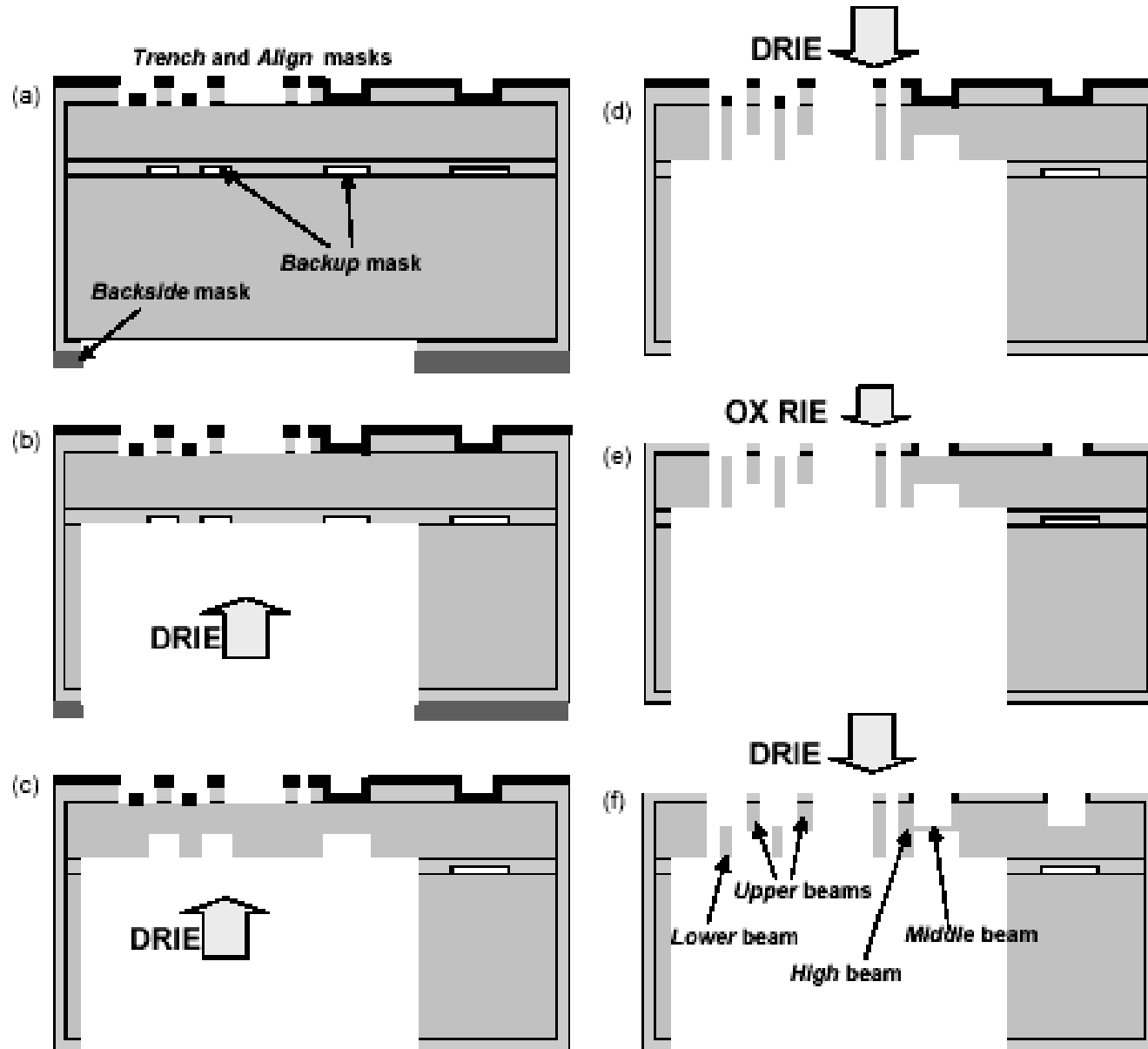


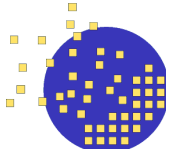
Comb vs. Parallel Plate

- Parallel Plate
 - Foundry Process
 - “Proven”
- Comb Drive
 - High Energy Density: Stroke, Frequency Response
 - Fabrication Challenges: Alignment, Assembly, Large Arrays
- MicroAssembly Approach
 - Reduce etch steps
 - “Disintegration” and Assembly vs. Monolithic



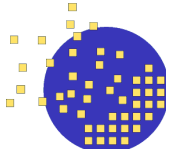
Earlier Comb Process (ARI, 2001)





Nanolaminate Bonding

- Bond to dummy substrates
- Bond to actuators from BMC
- Low temperature thermocompression process
- Print-through concerns
- Edge effects
- Subcontract from LLNL



Nanolaminate Bonding: 1st Result

Surface Stats:

Ra: 491.80 nm

Rq: 611.67 nm

Rt: 6.17 μm

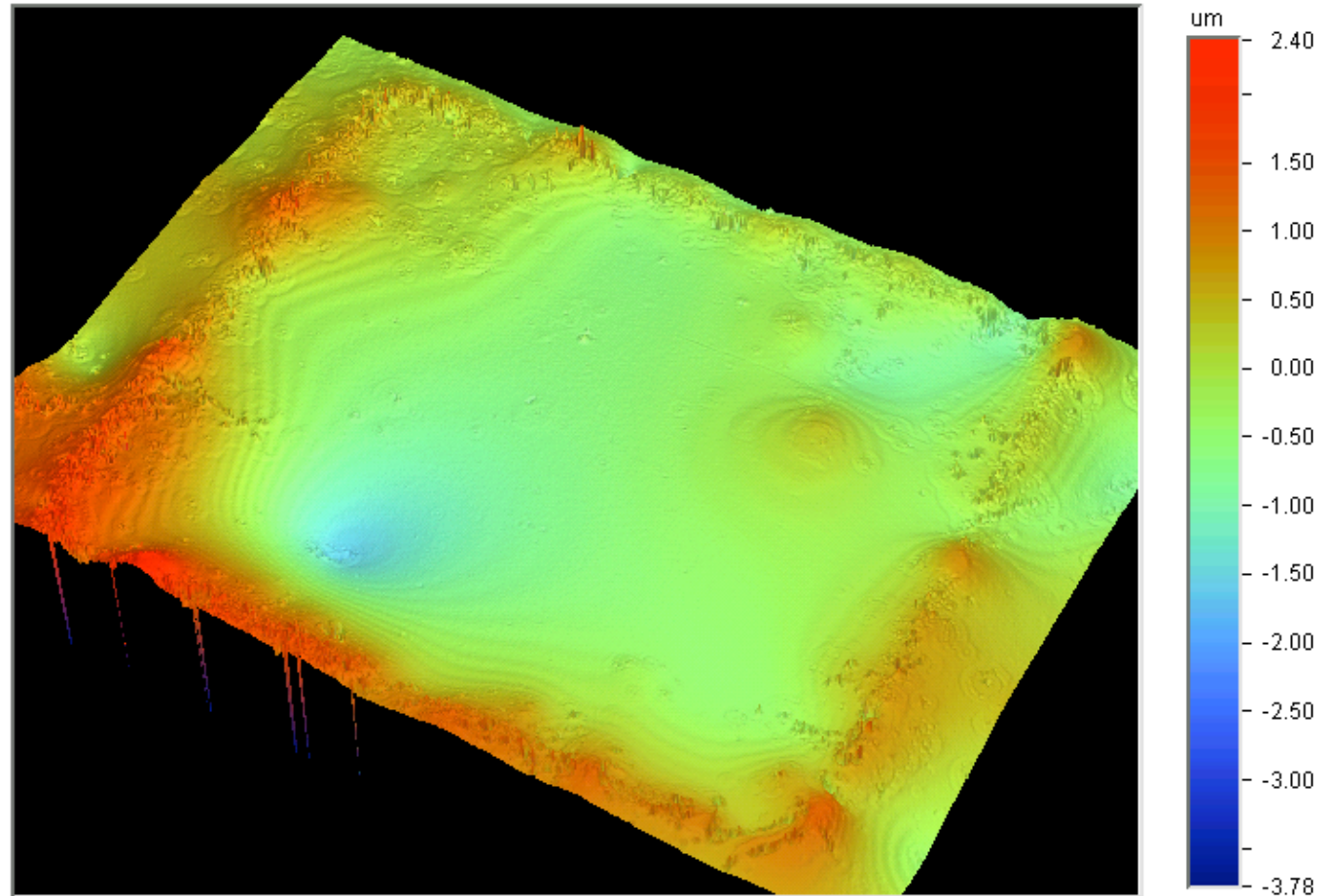
Measurement Info:

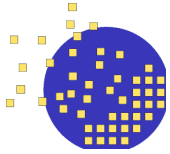
Magnification: 5.17

Measurement Mode: VSI

Sampling: 1.63 μm

Array Size: 736 X 480





Latest Bonding Result

Surface Stats:

Ra: 129.24 nm

Rq: 247.88 nm

Rt: 4.82 um

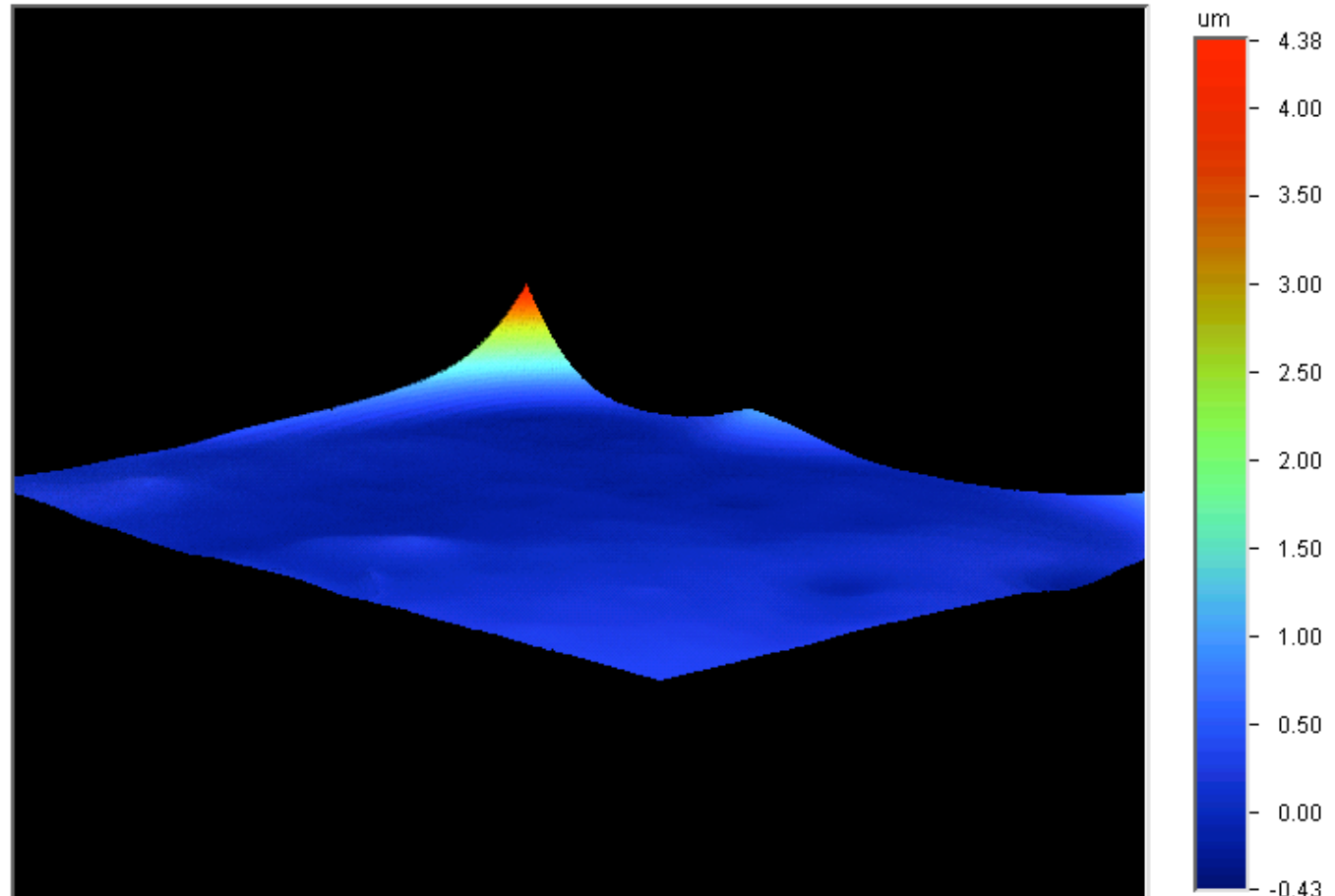
Measurement Info:

Magnification: 1.02

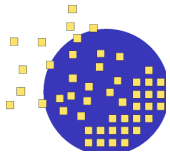
Measurement Mode: VSI

Sampling: 8.20 um

Array Size: 736 X 480



Title:



Latest Bonding Result

Surface Statistics:

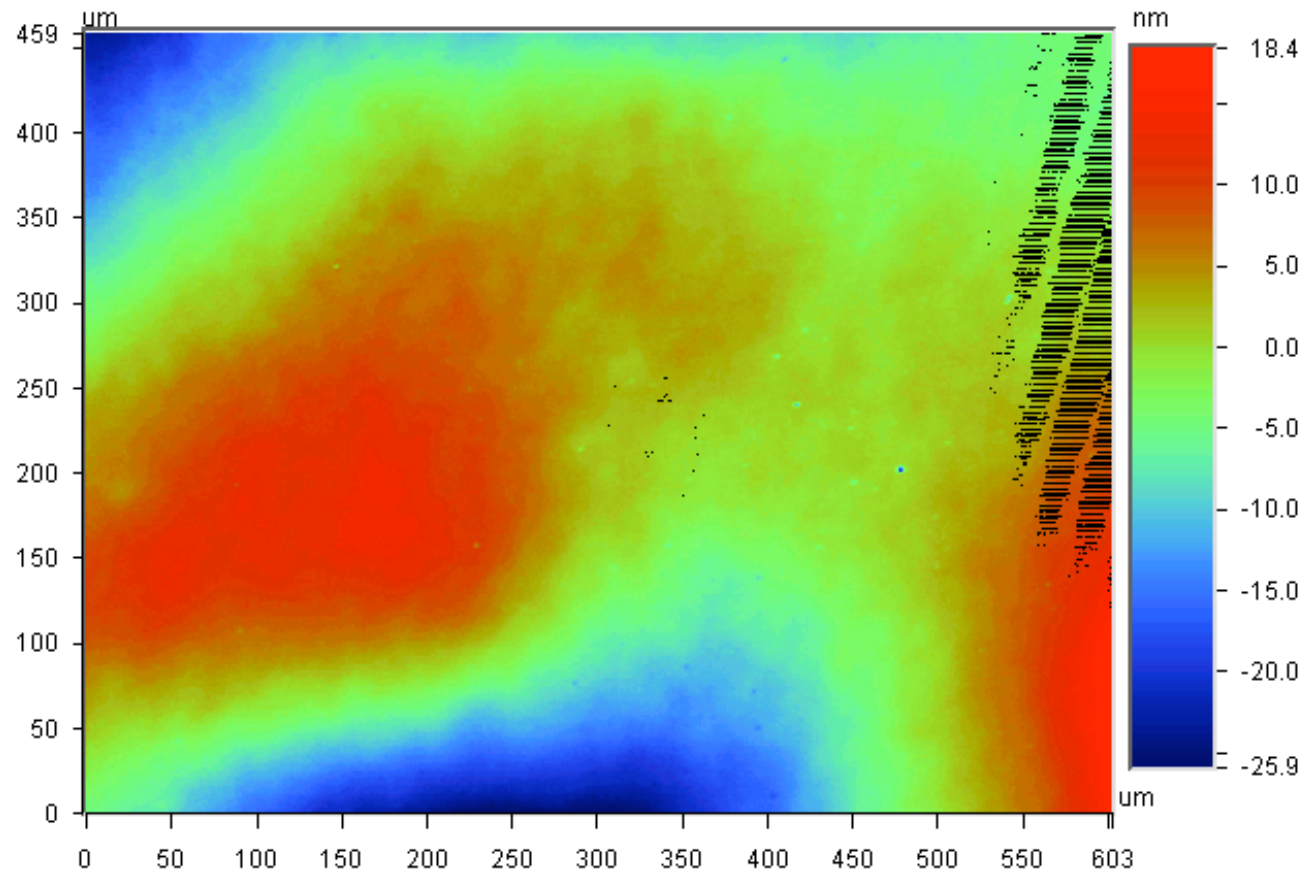
Ra: 5.95 nm
Rq: 7.73 nm
Rz: 43.50 nm
Rt: 44.26 nm

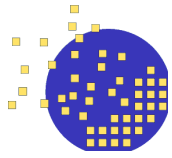
Set-up Parameters:

Size: 736 X 480
Sampling: 820.31 nm

Processed Options:

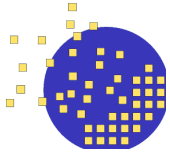
Terms Removed:
Tilt
Filtering:
None





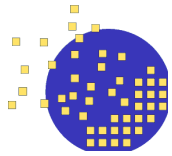
Latest Bonded Sample





Next Steps

- MEMS SLM
 - Drive Electronics
 - MEMS Fabrication Iterations
- Collaboration with LLNL and Other System Designers
- Nanolaminate Bonding
 - Larger Substrates
 - Edge Effects
 - Actuator-Nanolaminate Bonding



Applications: Free Space Optics Telecom, Imaging, Targeting, Ophthalmic, Tweezers

